

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/615,567 BONART ET AL.	
		Examiner	Art Unit M. Wilczewski	Page 1 of 1 2822

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,954,854	09-1990	Dhong et al.	257/332
	B	US-5,404,038	04-1995	Morihara, Toshinori	257/329
	C	US-5,434,435	07-1995	Baliga, B. Jayant	257/141
	D	US-6,525,403	02-2003	Inaba et al.	257/618
	E	US-5,940,707	08-1999	Gardner et al.	438/270
	F	US-5,763,310	06-1998	Gardner, Mark I.	438/270
	G	US-6,015,725	01-2000	Hirayama, Teruo	438/156
	H	US-2002/0102784	08-2002	Lee et al.	438/206
	I	US-2002/0098655	07-2002	Zheng et al.	438/268
	J	US-2001/0044190	11-2001	Heo et al.	438/270
	K	US-6,770,534	08-2004	Cho et al.	438/268
	L	US-6,455,377	09-2002	Zheng et al.	438/268
	M	US-6,436,770	08-2002	Leung et al.	438/268

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2-71556	03-1990	JAPAN	Nitayama et al.	
	O	JP 63-296281	12-1988	JAPAN	Kase, Masataka	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.